

**Search Notes**

Application/Control No.

10/789,746

Examiner

Steven S. Paik

Applicant(s)/Patent under  
Reexamination

WASHINGTON ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	379		
	381		
	383		
901	13		
	14		
271	117		
	147		
705	43	2/17/2005	SSP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
same as	above	2/17/2005	SSP

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST		
Text search, PLUS		
Consulted with D. Lee in AU 2876	2/17/2005	SSP